Search Notes



Application/Control No.	Applicant(s)/Patent u Reexamination	Applicant(s)/Patent under Reexamination	
09/977,808	HAYASHI, MORIHIKO		
Examiner	Art Unit		
Jude J. Jean-Gilles	2143		

SEARCHED				
Class	Subclass	Date	Examiner	
709	237	3/15/2006	JG	
713	160 181	3/15/2006	JG	
380	277-279	3/15/2006	JG	
<u>-</u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
379	209 216	3/15/2006	JG	
705	72	3/15/2006	JG	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST tool: DERWENT USPAT EPO JPO	3/15/2006	JG	
PAM tool: Effective Filing Date Double Patenting	3/15/2006	JG	
Internet: google.com onelook.com IEEE NPL's	3/15/2006	JG	
Primary consulted: Patrice Winter: search strategy and claim interpretation	3/14/2006	JG	
SPE consulted: Maung, Zarni; Wiley David: allowable subject matter	3/14/2006	JG	